

Search Notes

Application/Control No.

10/537,830

Examiner

TAN X. DINH

Applicant(s)/Patent under
Reexamination

HIRAI, HIDEAKI

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (see search history printout)	6/28/2007	T.D